

Special Issue

Fraud Detection or Prevention Technologies

Message from the Guest Editor

COVID-19 has dramatically increased the number of different fraud issues in the world. Fraud costs the global economy over USD 5 trillion as of 2019. There are many types of fraud: payroll fraud, asset misappropriation, invoice fraud, financial statement fraud, tax fraud, identity theft, insurance fraud, banking fraud, money fraud, digital exploitation, and fraud in organizations or (local) government. The goal of this Special Issue is to reduce local or global fraud and to strengthen the resilience of a society, organization, or private entity against fraud. The Special Issue is interested in any types of fraud detection or prevention technologies or applications. Articles in the Special Issue include original articles, review articles, tutorials, case studies, and software articles.

Guest Editor

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About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal *Applied Sciences* has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

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